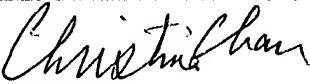


<b>Issue Classification</b>				Application/Control No.		Applicant(s)/Patent under Reexamination	
				09/277,575		NEWELL, MARTHA KAREN	
				Examiner		Art Unit	
				F. Pierre VanderVegt		1644	

<b>ISSUE CLASSIFICATION</b>							
<b>ORIGINAL</b>		<b>CROSS REFERENCE(S)</b>					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
424	143.1	424	152.1	155.1	184.1		
<b>INTERNATIONAL CLASSIFICATION</b>		514	2	44			
A	6	1	K	39/00	435	320.1	
A	6	1	K	39/395			
C	1	2	N	15/00			
A	0	1	N	43/04			
			/				

F. Pierre VanderVegt 10/29/07 (Assistant Examiner) (Date)		 <b>CHRISTINA CHAN</b> <b>SUPERVISORY PATENT EXAMINER</b> <small>(Technology Center 1600)</small> <i>10/29/07</i>	Total Claims Allowed: 10	
(Legal Instruments Examiner) (Date)			O.G. Print Claim(s) 1	O.G. Print Fig. None

<input checked="" type="checkbox"/> Claims renumbered in the same order as presented by applicant		<input type="checkbox"/> CPA		<input type="checkbox"/> T.D.		<input type="checkbox"/> R.1.47	
Final	Original	Final	Original	Final	Original	Final	Original
1	3	31	61	91	121	151	181
2	4	32	62	92	122	152	182
5		33	63	93	123	153	183
6		34	64	94	124	154	184
7		35	65	95	125	155	185
8		36	66	96	126	156	186
3	8	37	67	97	127	157	187
9		38	68	98	128	158	188
4	10	39	69	99	129	159	189
5	11	40	70	100	130	160	190
6	12	41	71	101	131	161	191
7	13	42	72	102	132	162	192
8		43	73	103	133	163	193
9		44	74	104	134	164	194
10		45	75	105	135	165	195
11		46	76	106	136	166	196
12		47	77	107	137	167	197
13		48	78	108	138	168	198
14		49	79	109	139	169	199
15		50	80	110	140	170	200
16		51	81	111	141	171	201
17		52	82	112	142	172	202
18		53	83	113	9	173	203
19		54	84	114	10	174	204
20		55	85	115	143	175	205
21		56	86	116	144	176	206
22		57	87	117	145	177	207
23		58	88	118	146	178	208
24		59	89	119	147	179	209
25		60	90	120	148	180	210